Notice of References Cited Application/Control No. 09/645,646 Examiner Hai Vo Applicant(s)/Patent Under Reexamination HAYASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,992,481	02-1991	von Bonin et al.	521/54
	В	US-			
	С	US-			
	Đ	US-			
	E	US-			
	F	US-		,	
	G	US-			
	Н	US-			
	ı	US-		·	
	J	US-	_		
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.